

<b>Notice of References Cited</b>	Application/Control No. <b>09/664,225</b>	Applicant(s)/Patent Under Reexam <b>Hedley</b>	
	Examiner <b>Dave Nguyen</b>	Art Unit <b>1632</b>	Page 1 of 1

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B	US 2002/0164721	11/2002	Firat et al.	435	91.1
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NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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